

<b>Notice of References Cited</b>	Application/Control No. 10/614,276		Applicant(s)/Patent Under Reexamination HAYAMA ET AL.	
	Examiner TUAN A. VU		Art Unit 2193	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,636,242	10-2003	Bowman-Amuah, Michel K.	715/764
*	B	US-7,346,921	03-2008	Murren et al.	726/1
*	C	US-7,051,316	05-2006	Charisius et al.	717/103
*	D	US-6,621,505	09-2003	Beauchamp et al.	715/764
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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